

Notice of References Cited

Application/Control No.

10/521,304

Applicant(s)/Patent Under
Reexamination
HOSHINO ET AL.

Examiner

BRIAN P. YENKE

Art Unit

2622

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,221,043	05-2007	Silverbrook, Kia	257/676
*	C	US-7,215,377	05-2007	Hoshino et al.	348/452
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*	E	US-7,295,245	11-2007	Ha, Tae-hyeun	348/452
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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